

SPECIFICATIONS

CIO-DAS801

CIO-DAS802

Analog Input & Digital I/O



**MEASUREMENT
COMPUTING™**

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Power consumption

+5V quiescent 500 mA typical, 750 mA max

Analog Input Section

A/D convertor type	AD674A, Successive Approximation
Resolution	12 bits
Number of channels	8
Programmable ranges (CIO-DAS801)	$\pm 10\text{V}$, $\pm 5\text{V}$, $\pm 1\text{V}$, $\pm 0.5\text{V}$, $\pm 0.1\text{V}$, $\pm 0.05\text{V}$, $\pm 0.01\text{V}$, $\pm 0.005\text{V}$, 0 to 10V, 0 to 1V, 0 to 0.1V, 0 to 0.01V
Programmable ranges (CIO-DAS802)	$\pm 10\text{V}$, $\pm 5\text{V}$, $\pm 2.5\text{V}$, $\pm 1.25\text{V}$, $\pm 0.625\text{V}$, 0 to 10V, 0 to 5V, 0 to 2.5V, 0 to 1.25V
A/D pacing	Programmable: internal counter or external source (IR Input / XCLK, falling edge) or software-pollled
A/D Trigger sources	External hardware (Digital In 1 / Trig, rising edge)
Data transfer	Interrupt or software-pollled from 256-sample FIFO buffer
Polarity	Unipolar/Bipolar programmable
Channel configuration	Differential (or pseudo-differential with installation of a SIP resistor) or single-ended, switch-selectable for each channel
DMA	None
A/D conversion time	20 μs
Throughput	50 kHz
Accuracy	$\pm 0.01\%$ of full scale ± 1 LSB typ, $\pm 0.05\%$ of full scale ± 1 LSB max
Differential Linearity error	± 0.5 LSB max
Integral Linearity error	± 1 LSB
No missing codes (guaranteed)	12 bits
Gain drift (A/D specs)	± 50 ppm/ $^{\circ}\text{C}$
Zero drift (A/D specs)	± 10 ppm/ $^{\circ}\text{C}$
Common Mode Range	$\pm 10\text{V}$
CMRR @ 60Hz	
Gain = 1	70 dB min
Gain = 10	90 dB min
Gain ≥ 100	100 dB min
Input leakage current (@ 25 deg C)	± 30 nA
Input leakage current (over temperature)	± 250 nA
Input impedance	>1000 Megohms typical
Absolute maximum input voltage	$\pm 35\text{V}$

Counter section

Counter type	82C54
Configuration	3 down-counters , 16 bit resolution
Counter 0 - independent user counter	
Source:	external, user connector (Counter 0 In)
Gate:	external, user connector (Gate 0)
Output:	user connector (Counter 0 Out)
Counter 1 - ADC Pacer Lower Divider or independent user counter	
Source:	user connector (Counter 1 In) and optionally, Counter 2 Out, selectable by software
Gate:	programmable, disabled or user connector (Gate 1)
Output:	user connector (Counter 1 Out) and optionally to A/D start convert, software selectable
Counter 2 - ADC Pacer Upper Divider	
Source:	internal 1MHz oscillator
Gate:	programmable, disabled or user connector (Gate 2)
Output:	user connector (Counter 2 Out) and optionally to counter 1 input, software selectable
Clock input frequency	10 MHz max
High pulse width (clock input)	30 ns min
Low pulse width (clock input)	50 ns min
Gate width high	50 ns min
Gate width low	50 ns min
Input low voltage	0.8V max
Input high voltage	2.0V min
Output low voltage	0.4V max
Output high voltage	3.0V min
Crystal oscillator	
Frequency	10 MHz
Frequency accuracy	100 ppm

Digital I/O section

Digital type	FPGA
Configuration	Two ports, 3 input and 4 output
Input low voltage	0.8V max
Input high voltage	2.0V min
Output low voltage (IOL = 4mA)	0.32V max
Output high voltage (IOH = -4mA)	3.86V min
Absolute maximum input voltage	-0.5V, +5.5V
Interrupts	Jumper selectable: levels 2, 3, 4, 5, 6, 7, or not connected
Positive edge triggered	
Interrupt enable	Programmable
Interrupt sources	External (IR Input / XCLK), A/D End-of-conversion, A/D FIFO-half-full

Environmental

Operating temperature range	0 to 50°C
Storage temperature range	-20 to 70°C
Humidity	0 to 90% non-condensing

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